

Enhancement Mode N+P-Channel Power MOSFET

 $SOT23-6/N+PMOS/40V/\pm20V/1.5V/4A/45.8m\Omega$

 $-40V/\pm 20V/-1.75V/-4A/98.8m\Omega$

Rev_{0.5}





40V N+P-Channel MOSFET

1.Features

- ◆ High power and current handing capability
- ◆ Lead free product is acquired
- Fast switching
- ◆ Surface mount package

2.Applications

- Power Switching Application
- ◆ Load Switching



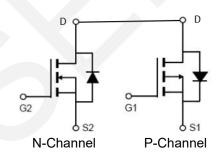
SOT23-06 Pin Description

♦ N-Channel

V _{DS}	R _{DS(on)} Typ.	l _D
40V	45.8mΩ @ 10V	4.0
	61.5mΩ @ 4.5V	4A

◆ P-Channel

V _{DS}	R _{DS(on)} Typ.	I _D	
-40V	98.8mΩ @ -10V	40	
	138.5mΩ @ -4.5V	-4A	



Schematic Diagram

3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.	
WP0406	0406	SOT23-6	3,000	180,000	

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter		Symbol	N-chanel	P-chanel	Units
Drain to Source Voltage		V _{DSS}	40	-40	V
Gate to Source Voltage		V _{GSS}	±20	±20	V
Drain Current (DC),	TA=25 °C	l _D	4	-4	Α
	TA=70 °C	l _D	2.8	-2.8	Α
Drain Current (Pulse), PW≤300μs		Ірм	16	-16	Α
Avalanche Energy, Single Pulsed		Eas	6.7	10.3	mJ
Total Dissipation TA=25 °C		P _D	0.6 0.6		W
Junction Temperature		Tj	150	150	°C



Parameter	Symbol	N-chanel	P-chanel	Units
Storage Temperature	T _{stg}	-55 to +150	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

5. Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Maximum Junction-to-Ambient	Reja	192	°C/W

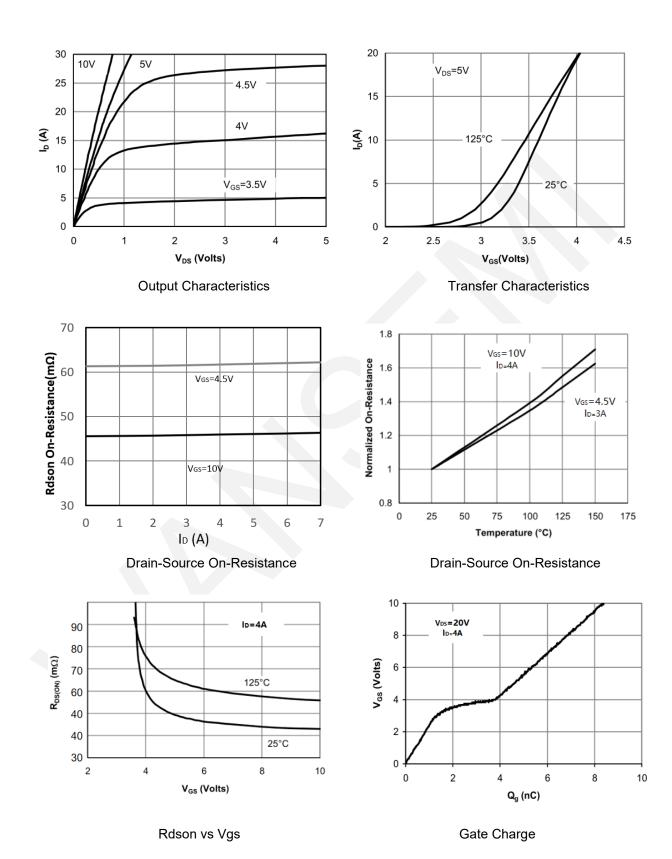
Note 2: When mounted on 1 inch square copper board $t \le 10$ sec The value in any given application depends on the user's specific board design.

6.NMOS Electrical Characteristics at Ta=25°C (Note 3)

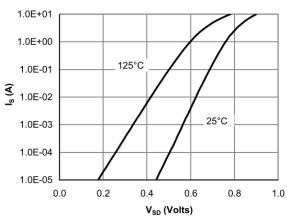
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	$I_D = 250 \mu A$, $V_{GS} = 0 V$	40			V
Zero-Gate Voltage Drain Current	I _{DSS}	V _{DS} = 40V, V _{GS} = 0V			1	μA
Gate to Source Leakage Current	I _{GSS}	$V_{GS} = \pm 20V$, $V_{DS} = 0V$			±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _{DS} =250µA	1.0	1.5	2.5	V
Static Drain to Source On-State	В	I _D = 3A, V _{GS} = 10V		45.8	60	mΩ
Resistance	R _{DS(on)}	I _D = 3A, V _{GS} = 4.5V		61.5	81	mΩ
Input Capacitance	C _{iss}	V _{GS} =0V,		371	-	pF
Output Capacitance	Coss	V _{DS} =15V,		170	-	pF
Reverse Transfer Capacitance	C _{rss}	Frequency=1.0MHz		58	-	pF
Turn-ON Delay Time	t _{d(on)}	V _{DD} = 20V		6.8	-	ns
Rise Time	t _r	$V_{GS} = 20V$		40.6	-	ns
Turn-OFF Delay Time	t _{d(off)}	$R_{GEN} = 2.5\Omega$		13.4	-	ns
Fall Time	t _f	I _D = 4A		2.7	-	ns
	Qg	V _{DS} = 20V,		5.1		nC
Total Gate Charge	Q _{gs}	V _{GS} = 10V,		1.3		nC
	Q_{gd}	I _D = 4A		1.5		nC
Diode Forward Voltage	V _{FSD}	I _S = 4A, V _{GS} = 0V		0.85	1.2	V



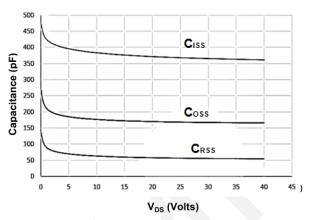
NMOS Typical electrical and thermal characteristics



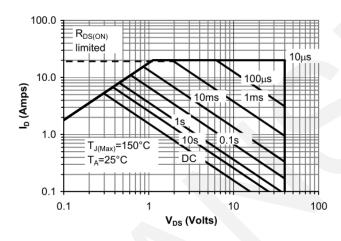




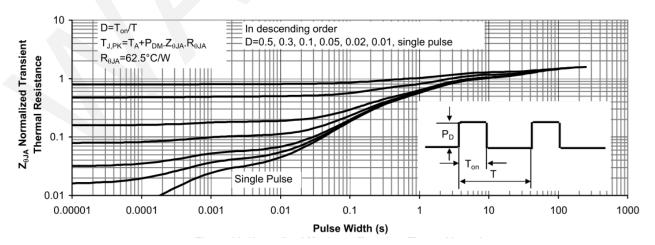




Capacitance vs Vds



Safe Operating Area



Normalized Maximum Transient Thermal Impedance



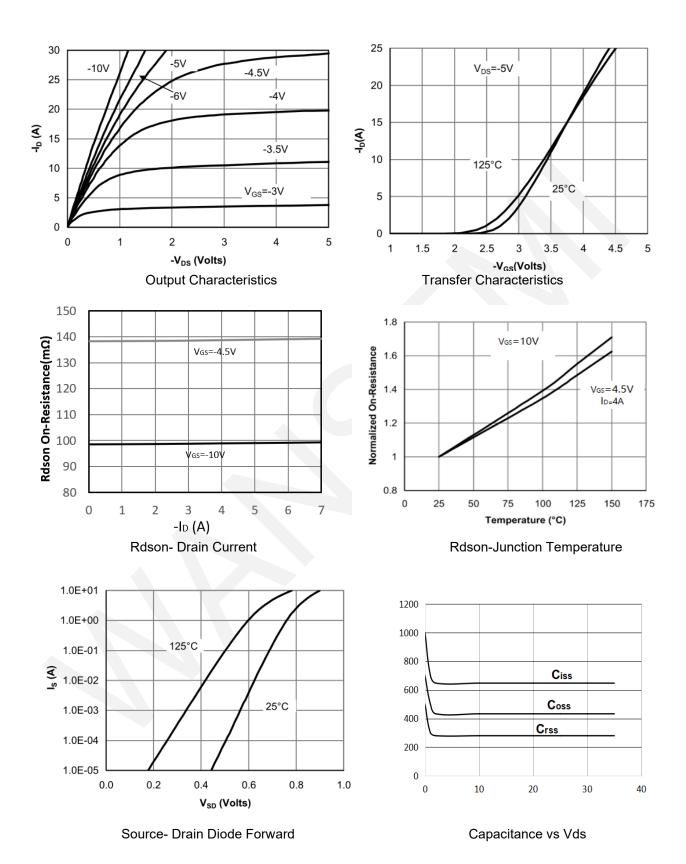
7.PMOS Electrical Characteristics at Ta=25°C(Note 3)

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	$I_D = -250 \mu A, V_{GS} = 0 V$	-40			V
Zero-Gate Voltage Drain Current	I _{DSS}	V _{DS} = -40V, V _{GS} = 0V			1	μΑ
Gate to Source Leakage Current	Igss	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	V _{DS} =V _{GS} , I _{DS} =-250μA	-1.0	-1.75	-2.5	V
Static Drain to Source On-State	Б	$I_D = -3A$, $V_{GS} = -10V$		98.8	125	mΩ
Resistance	R _{DS(on)}	I _D = -3A, V _{GS} =-4.5V		138.5	170	mΩ
Input Capacitance	Ciss	V _{GS} =0V,		647	1	pF
Output Capacitance	Coss	V _{DS} =-15V,		433	-	pF
Reverse Transfer Capacitance	Crss	Frequency=1.0MHz		280	_	pF
Turn-ON Delay Time	t _{d(on)}	V _{DD} = -20V		6.5	-	ns
Rise Time	t _r	$I_D = -4A$		14	-	ns
Turn-OFF Delay Time	t _{d(off)}	V _{GS} = -10V		34	-	ns
Fall Time	t _f	$R_{GEN} = 2.5\Omega$		18	-	ns
	Qg	V _{DS} = -20V,		13.5		nC
Total Gate Charge	Qgs	V _{GS} = -10V,		1.5		nC
	Q _{gd}	I _D = -4A		1.8		nC
Diode Forward Voltage	V _{FSD}	I _S = -4A, V _{GS} = 0V		-0.9	-1.2	V

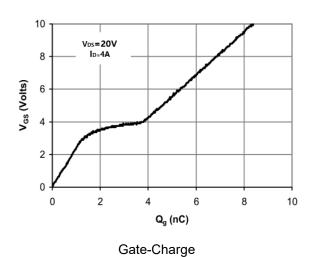
Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different condit

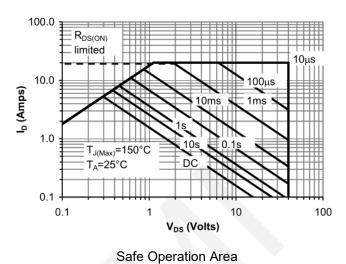


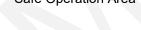
PMOS Typical electrical and thermal characteristics

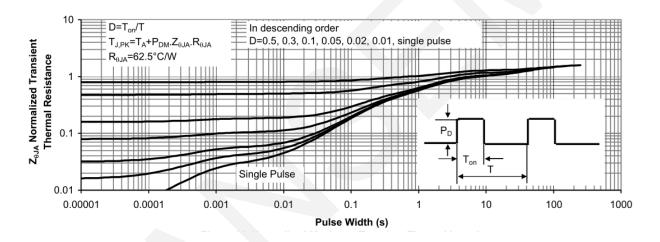










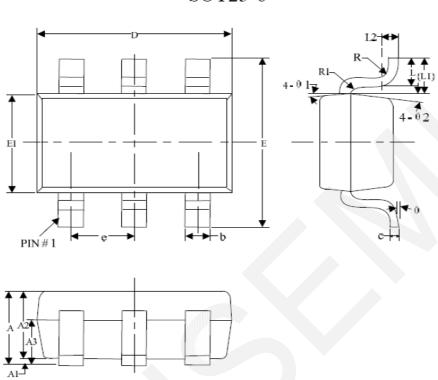


Normalized Maximum Transient Thermal Impedance



8.Package Dimensions





Dimensions (unit: mm)

SYMBOL	MIN	NOM	MAX	SYMBOL	MIN	NOM	MAX
Α	-		1.30	е	0.85	0.95	1.05
A1	0	-	0.15	L	0.35	0.45	0.60
A2	0.90	1.10	1.30	L1	0.59REF		
A3	0.60	0.65	0.70	L2	0.25BSC		
b	0.39	_	0.49	R	0.05	-	-
С	0.12	_	0.19	R1	0.05	-	0.02
D	2.85	2.95	3.15	θ	0°	-	8°
Е	2.60	2.80	3.00	91	3°	5°	7°
E1	1.55	1.65	1.75	θ2	6°	8°	10°



9. Important Notice

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